

# TEST REPORT

**Applicant:** Shenzhen LinkedSparx Technology Co., Ltd  
**Address:** 606, 82, 4th Industrial Park, Tantou, Songgang,  
Bao'an District, Shenzhen City, China.  
**Equipment Type:** SYRO-Bricks  
**Model Name:** LS-B3  
**Brand Name:** LinkedSparx  
**Test Standard:** ANSI/IEEE Std 149-1979  
**Test Date:** Oct. 12, 2022  
**Date of Issue:** Oct. 17, 2022

**ISSUED BY:**

Shenzhen BALUN Technology Co., Ltd.



**Tested by:** Mai Jintian

**Checked by:** Tolan Tu

**Approved by:** Wei Yanquan  
(Chief Engineer)

*Mai Jintian*

*Tolan Tu*

*Wei Yanquan*

### Revision History

| Version        | Issue Date           | Revisions            |
|----------------|----------------------|----------------------|
| <u>Rev. 01</u> | <u>Oct. 17, 2022</u> | <u>Initial Issue</u> |

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# 1 GENERAL INFORMATION

## 1.1 Test Laboratory

|              |                                                                                                                              |
|--------------|------------------------------------------------------------------------------------------------------------------------------|
| Name         | Shenzhen BALUN Technology Co., Ltd.                                                                                          |
| Address      | Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China |
| Phone Number | +86 755 6685 0100                                                                                                            |

## 1.2 Test Location

|          |                                                                                                                                                                                                                         |
|----------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Name     | Shenzhen BALUN Technology Co., Ltd.                                                                                                                                                                                     |
| Location | <input checked="" type="checkbox"/> Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China                                                        |
|          | <input type="checkbox"/> 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China |

## 2 PRODUCT INFORMATION

### 2.1 Applicant Information

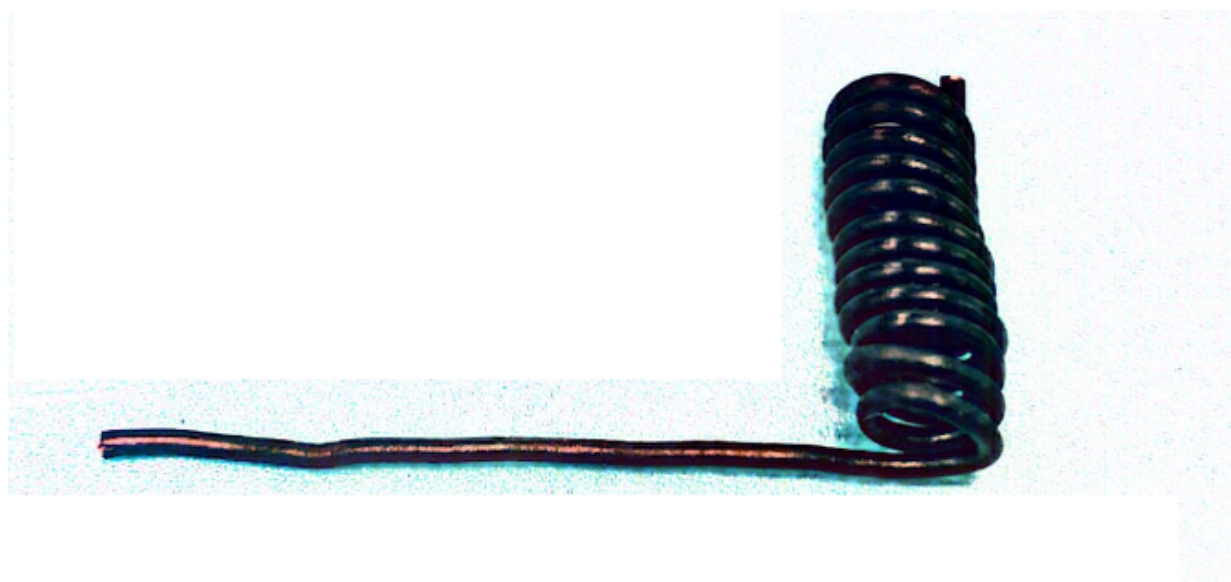
|           |                                                                                        |
|-----------|----------------------------------------------------------------------------------------|
| Applicant | Shenzhen LinkedSparx Technology Co., Ltd                                               |
| Address   | 606, 82, 4th Industrial Park, Tantou, Songgang, Bao'an District, Shenzhen City, China. |

### 2.2 Manufacturer Information

|              |                                                                                                                               |
|--------------|-------------------------------------------------------------------------------------------------------------------------------|
| Manufacturer | Shenzhen Intermediate Technology Co., Ltd                                                                                     |
| Address      | Room 703, Baofeng Building, No.2006 Dongmen South Road, Xinnan Community, Nanhu Street, Luohu District, Shenzhen City, China. |

### 2.3 General Description for Equipment under Test (EUT)

|                       |             |
|-----------------------|-------------|
| EUT Name              | SYRO-Bricks |
| Model Name Under Test | LS-B3       |
| Antenna Type          | Antenna     |
| Dimensions            | 15*35mm     |



## 2.4 Ancillary Equipment

Note: Not applicable.

## 2.5 Technical Information

|                  |                                                                                                      |
|------------------|------------------------------------------------------------------------------------------------------|
| Test Frequencies | 2400MHz, 2410MHz, 2420MHz, 2430MHz, 2440MHz, 2450MHz,<br>2460MHz, 2470MHz, 2480MHz, 2490MHz, 2500MHz |
|------------------|------------------------------------------------------------------------------------------------------|

### 3 SUMMARY OF TEST RESULTS

#### 3.1 Test Standards

| No. | Identity               | Document Title                             |
|-----|------------------------|--------------------------------------------|
| 1   | ANSI/IEEE Std 149-1979 | IEEE Standard Test Procedures for Antennas |

#### 3.2 Test Verdict

| Report Section | Description         | Remark |
|----------------|---------------------|--------|
| ANNEX A.1      | Gain and Efficiency | --     |
| ANNEX B        | Radiation Pattern   | --     |

#### 3.3 Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

| Item | Uncertainty         |
|------|---------------------|
| Gain | $\pm 1.92\text{dB}$ |

## 4 GENERAL TEST CONFIGURATIONS

### 4.1 Test Condition

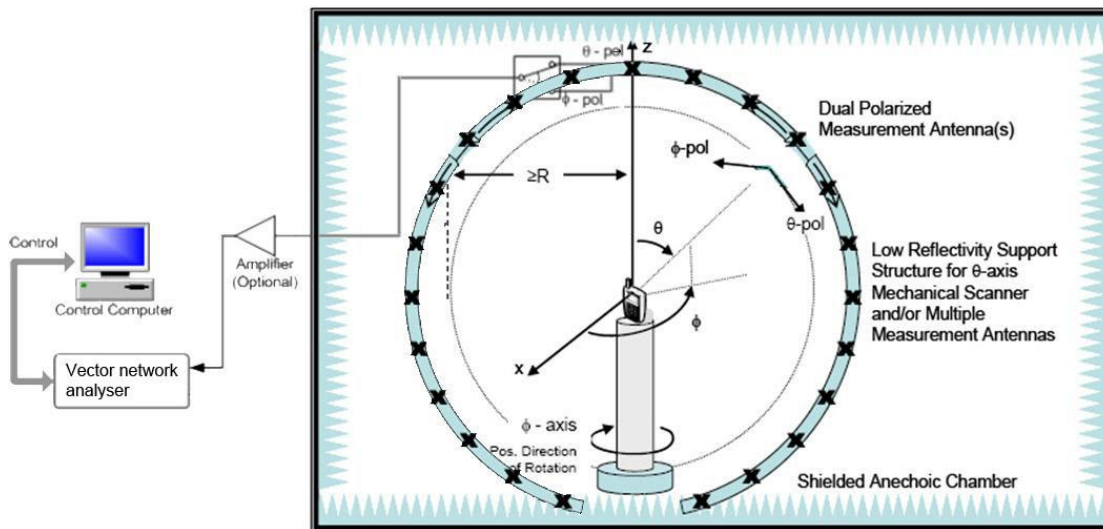
| Environment<br>Parameter                           | Selected Values During Tests |                 |         |                          |
|----------------------------------------------------|------------------------------|-----------------|---------|--------------------------|
|                                                    | Ambient<br>Pressure(KPa)     | Temperature(°C) | Voltage | Relative<br>Humidity (%) |
| Normal<br>Temperature,<br>Normal Voltage<br>(NTNV) | 101                          | 25              | N/A     | 50                       |

### 4.2 Test Equipment List

| Description                                       | Manufacturer | Model  | Serial No.       | Cal. Date  | Cal. Due   |
|---------------------------------------------------|--------------|--------|------------------|------------|------------|
| SG24 Multi-probe<br>Antenna Measurement<br>System | SATIMO       | SG24-L | 1101855-<br>0001 | 2021.11.12 | 2024.11.11 |
| Vector Network<br>Analyzer                        | Agilent      | E5071B | MY42404001       | 2022.04.02 | 2023.04.01 |
| Description                                       | Manufacturer | Name   |                  | Version    |            |
| Test Software                                     | MVG          | SPM    |                  | V 1.8      |            |

## 4.3 Test Setup

### 4.3.1 Antenna gain, efficiency and radiation pattern test setup



## ANNEX A TEST RESULTS

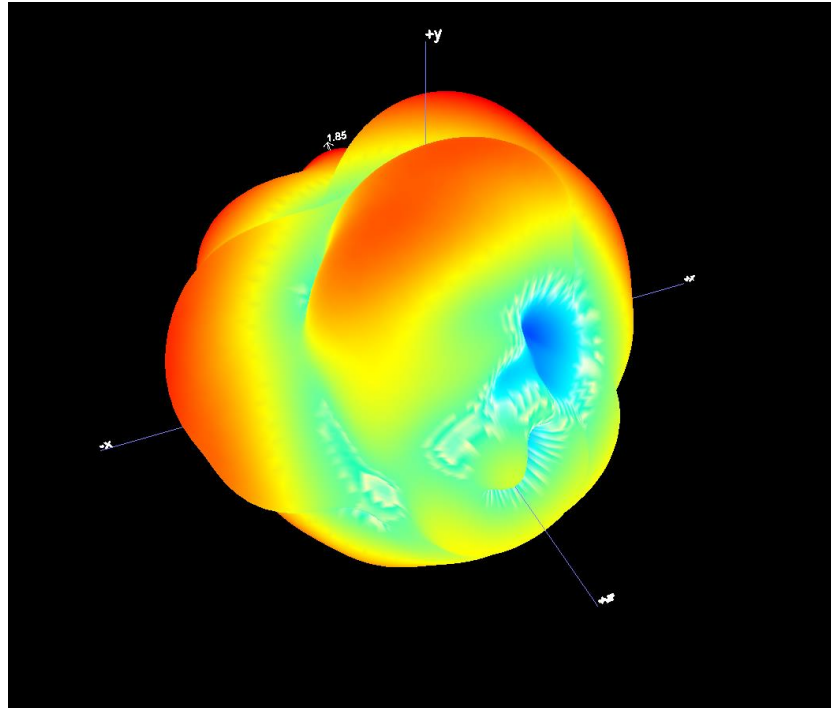
### A.1 Gain and Efficiency

| Frequency | Gain (dBi)   | Efficiency (%) |
|-----------|--------------|----------------|
| 2400MHz   | <b>-1.85</b> | <b>37</b>      |
| 2410MHz   | -1.61        | 36             |
| 2420MHz   | -1.39        | 35             |
| 2430MHz   | -1.30        | 34             |
| 2440MHz   | -1.04        | 33             |
| 2450MHz   | 0.00         | 32             |
| 2460MHz   | -0.59        | 30             |
| 2470MHz   | -0.73        | 30             |
| 2480MHz   | -0.65        | 30             |
| 2490MHz   | -0.39        | 28             |
| 2500MHz   | -0.21        | 27             |

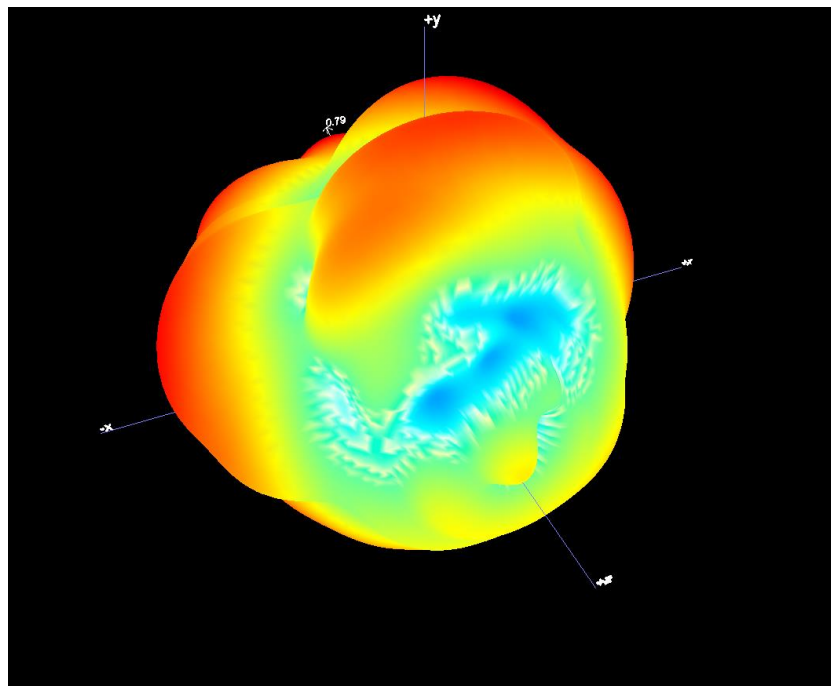
## ANNEX B RADIATION PATTERN

### B.1 3D Pattern

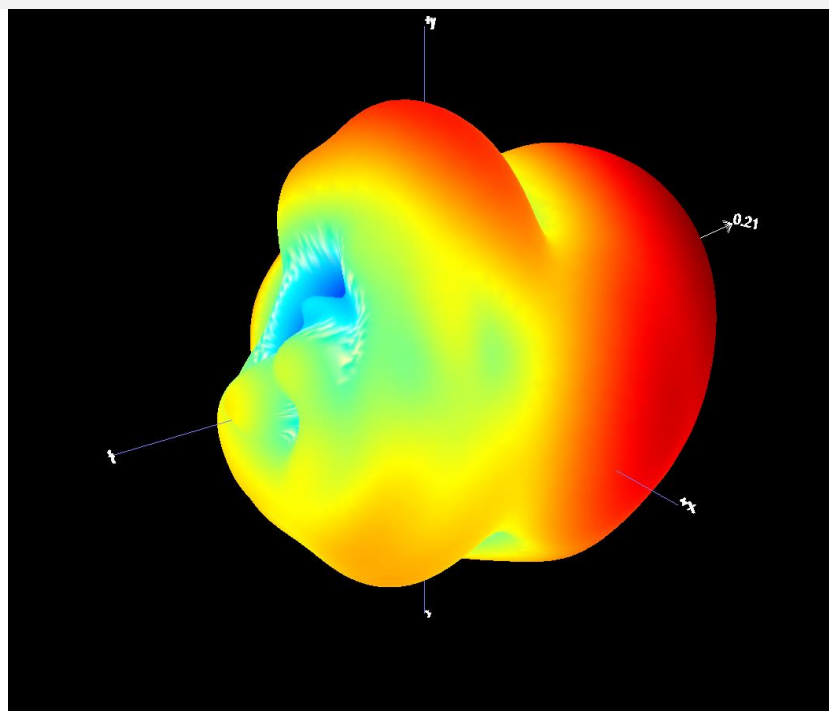
B1.1 3D Pattern for 2400MHz



B1.2 3D Pattern for 2450MHz

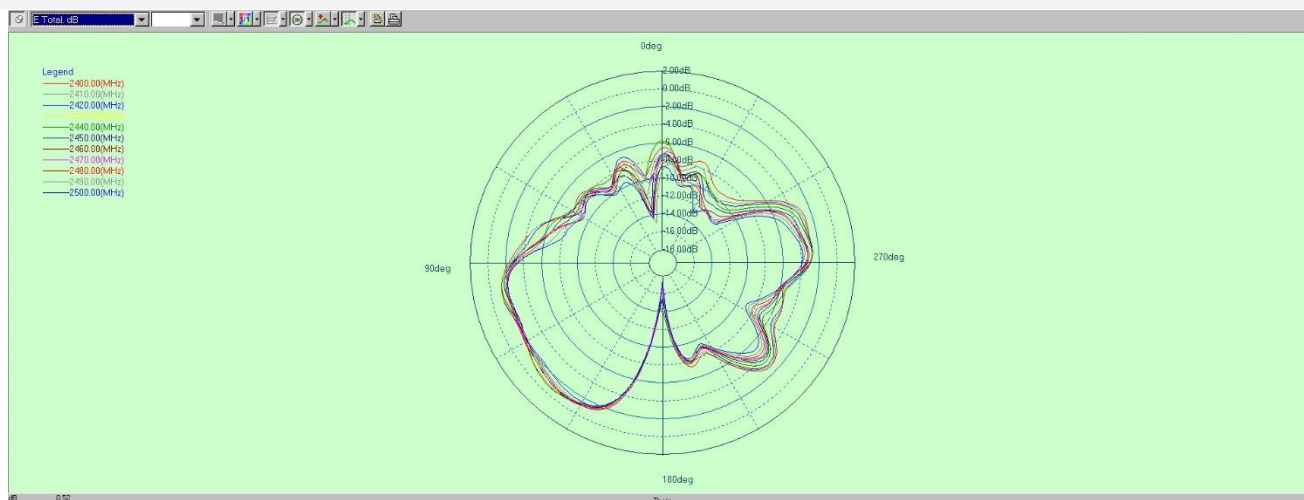


B1.3 3D Pattern for 2500MHz

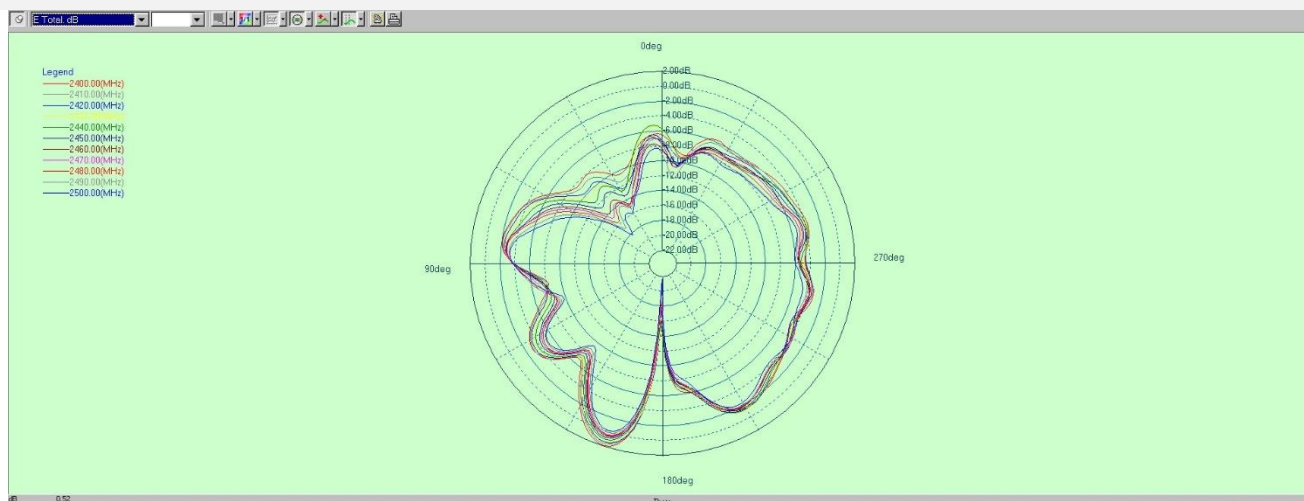


## B.2 1D Radiation Pattern

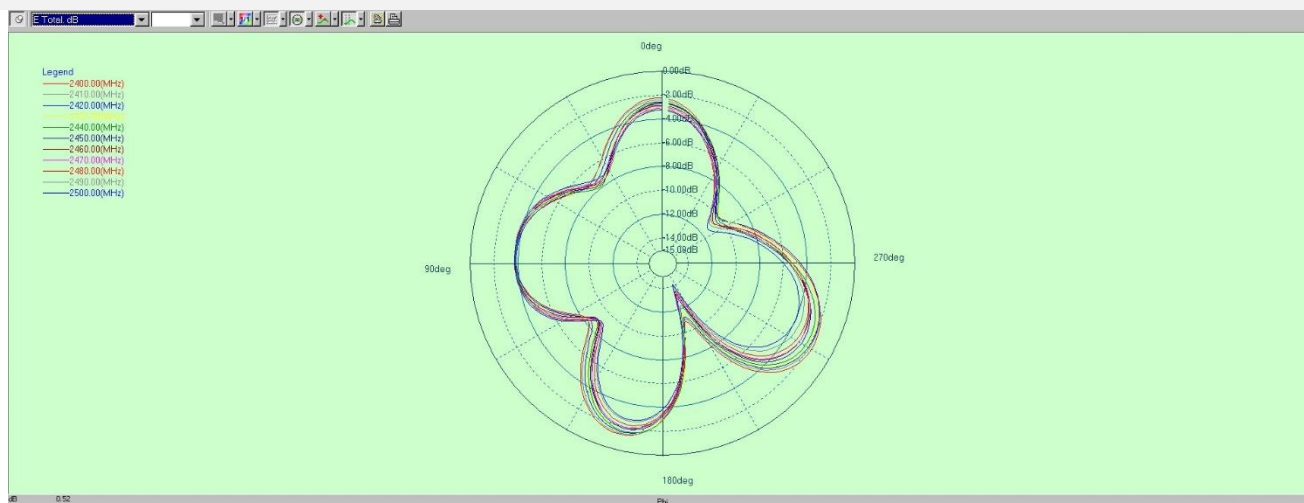
### B2.1 PHI=0



### B2.2 PHI=90



### B2.3 THETA=90



## **ANNEX C TEST SETUP PHOTOS**

Please refer the document “BL-SZ22A0289-AO.PDF”.

## **ANNEX D EUT PHOTO**

Please refer the document “BL-SZ22A0289-AA.PDF”.

## Statement

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--END OF REPORT--